Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination SHEI, STEVEN M.	
10/611,295		
Examiner	Art Unit	
Joseph M. Pelham	3742	

SEARCHED					
Class	Subclass	Date	Examiner		
			,		

INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
219/394,411			
220/367.1			
219/394,411 220/367.1 See history	3/4/00	4	